

AOD2606

60V N-Channel MOSFET

General Description

The AOD2606 uses Trench MOSFET technology that is uniquely optimized to provide the most efficient high frequency switching performance. Both conduction and switching power losses are minimized due to an extremely low combination of R_{DS(ON)}, Ciss and Coss. This device is ideal for boost converters and synchronous rectifiers for consumer, telecom, industrial power supplies and LED backlighting.

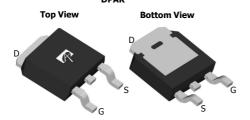
Product Summary

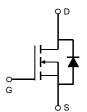
 $\begin{array}{ll} V_{DS} & 60V \\ I_D \ (at \ V_{GS} \! = \! 10V) & 46A \\ R_{DS(ON)} \ (at \ V_{GS} \! = \! 10V) & < 6.8 m\Omega \end{array}$

100% UIS Tested 100% R_g Tested



TO252 DPAK





Parameter		Symbol	Maximum	Units
Drain-Source Voltage		V _{DS}	60	V
Gate-Source Voltage		V _{GS}	±20	V
Continuous Drain	T _C =25℃		46	
Current G	T _C =100℃	I _D	36	A
Pulsed Drain Current C		I _{DM}	184	
Continuous Drain	T _A =25℃		14	۸
Current	T _A =70℃	IDSM	11	A
Avalanche Current ^C		I _{AS}	60	А
Avalanche energy L=0.1mH ^C		E _{AS}	180	mJ
	T _C =25℃	P _D	150	W
Power Dissipation B	T _C =100℃	r _D	75	VV
	T _A =25℃	В	2.5	10/
Power Dissipation ^A	T _A =70℃	P _{DSM}	1.6	W
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 175	C

Thermal Characteristics								
Parameter	Symbol	Тур	Max	Units				
Maximum Junction-to-Ambient A	t ≤ 10s	D	16	20	℃/W			
Maximum Junction-to-Ambient AD	Steady-State	$R_{\theta JA}$	41	50	℃/W			
Maximum Junction-to-Case Steady-		$R_{\theta JC}$	0.8	1	℃/W			



Electrical Characteristics (T_J=25℃ unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units		
STATIC PARAMETERS									
BV _{DSS}	Drain-Source Breakdown Voltage	I _D =250μA, V _{GS} =0V		60			V		
I _{DSS}	Zero Gate Voltage Drain Current	V_{DS} =60V, V_{GS} =0V	T _J =55℃			1 5	μΑ		
I _{GSS}	Gate-Body leakage current	$V_{DS}=0V$, $V_{GS}=\pm20V$				±100	nA		
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS,}I_{D}=250\mu A$		2.5	3	3.5	V		
I _{D(ON)}	On state drain current	V _{GS} =10V, V _{DS} =5V		184			Α		
R _{DS(ON)}	Static Drain-Source On-Resistance	V_{GS} =10V, I_D =20A	T _J =125℃		5.6 8.8	6.8 10.6	mΩ		
g _{FS}	Forward Transconductance	V_{DS} =5V, I_{D} =20A			75		S		
V_{SD}	Diode Forward Voltage	I _S =1A,V _{GS} =0V			0.7	1	V		
Is	Maximum Body-Diode Continuous Current ^G					46	Α		
DYNAMIC	PARAMETERS								
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =30V, f=1MHz			4050		pF		
Coss	Output Capacitance				345		pF		
C _{rss}	Reverse Transfer Capacitance				16.8		pF		
R_g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz		0.3	0.65	1.0	Ω		
SWITCHI	NG PARAMETERS								
$Q_g(10V)$	Total Gate Charge	V _{GS} =10V, V _{DS} =30V, I _D =20A			53	75	nC		
Q _g (4.5V)	Total Gate Charge				22	31	nC		
Q_{gs}	Gate Source Charge				17		nC		
Q_{gd}	Gate Drain Charge				5		nC		
$t_{D(on)}$	Turn-On DelayTime	V_{GS} =10V, V_{DS} =30V, R_L =1.5 Ω , R_{GEN} =3 Ω			18		ns		
t _r	Turn-On Rise Time				20		ns		
$t_{D(off)}$	Turn-Off DelayTime				33		ns		
t _f	Turn-Off Fall Time				4		ns		
t _{rr}	Body Diode Reverse Recovery Time	I _F =20A, dI/dt=500A/μs			26		ns		
Q_{rr}	Body Diode Reverse Recovery Charge	I_F =20A, dI/dt=500A/ μ s			125		nC		

A. The value of $R_{\theta,JA}$ is measured with the device mounted on $1in^2$ FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C. The Power dissipation P_{DSM} is based on R $_{\theta JA}$ and the maximum allowed junction temperature of 150 $^{\circ}$ C. The value in any given application depends on the user's specific board design, and the maximum temperature of 175 $^\circ$ C may be used if the PCB allows it.

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B. The power dissipation P_D is based on T_{JIMAXI}=175° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature T_{J(MAX)}=175° C. Ratings are based on low frequency and duty cycles to keep initial T_J=25° C.

D. The $R_{\theta JA}$ is the sum of the thermal impedance from junction to case $R_{\theta JC}$ and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300µs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(MAX)}$ =175° C. The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited.

H. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25° C.

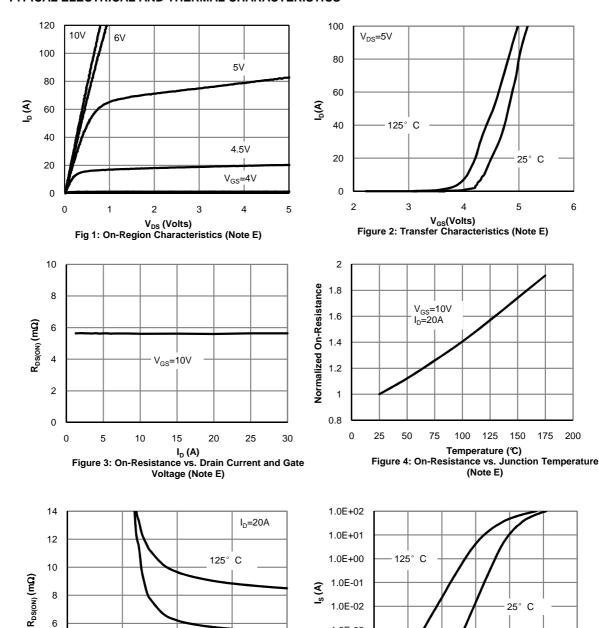


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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



1.0E-03

1.0E-04 1.0E-05

0.0

V_{SD} (Volts)

Figure 6: Body-Diode Characteristics (Note E)

10

25° C

8

V_{GS} (Volts)

Figure 5: On-Resistance vs. Gate-Source Voltage

(Note E)



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

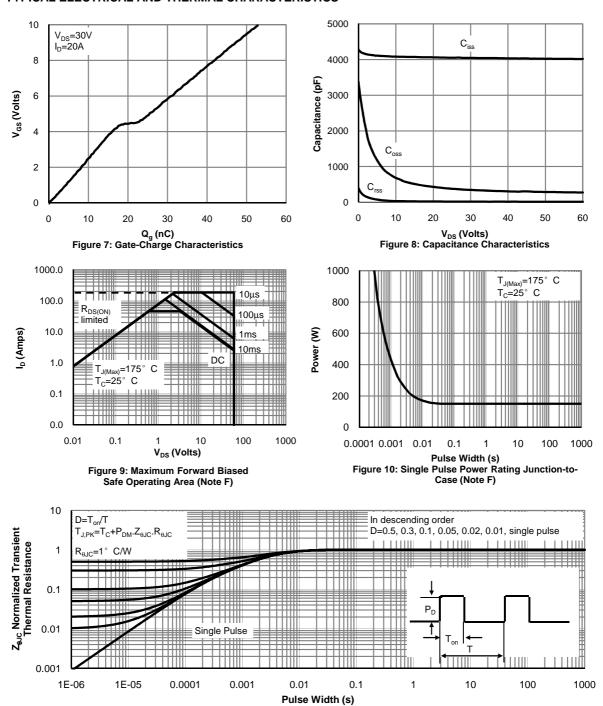
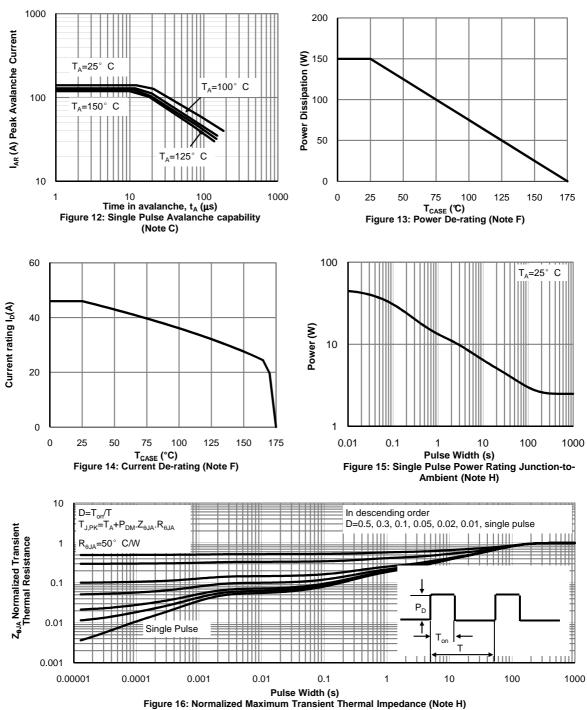


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

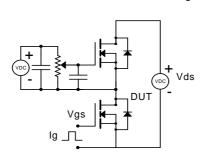


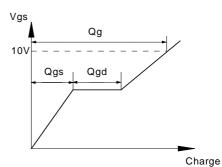
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



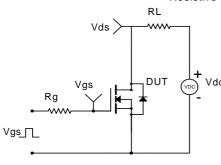


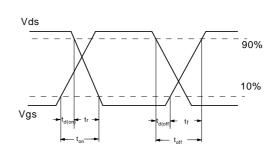
Gate Charge Test Circuit & Waveform



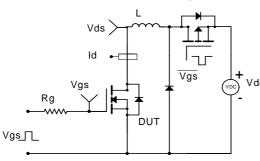


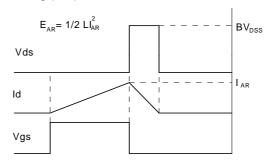
Resistive Switching Test Circuit & Waveforms





Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

